Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination NAGATOMO ET AL.	
10/791,801		
Examiner	Art Unit	
Amy R. Cohen	2859	

SEARCHED					
Class	Subclass	Date	Examiner		
399	175	5/5/2005	ARC		
	174				
	176				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEA	H NOTES ARCH STRATEGY	<u>')                                    </u>
	DATE	EXMR
Royer, class 399	5/5/2005	ARC